

(21) Application No: **0412179.4**
(22) Date of Filing: **01.06.2004**

(71) Applicant(s):
Nokia Corporation
(Incorporated in Finland)
Keilalahdentie 4, FIN-02150 Espoo, Finland

(72) Inventor(s):
Thomas Füssinger
Dennis Thompson

(74) Agent and/or Address for Service:
Venner Shipley LLP
20 Little Britain, LONDON, EC1A 7DH,
United Kingdom

(51) INT CL⁷:
G01R 31/02 , H05K 1/11

(52) UK CL (Edition X):
H1R RAV
G1U UR3102

(56) Documents Cited:
GB 2047973 A **US 5877033 A**

(58) Field of Search:
UK CL (Edition X) **G1U, H1R**
INT CL⁷ **G01R, H05K**
Other: **ONLINE DATABASES: WPI, EPODOC**

(54) Abstract Title: **Detecting short circuits**

(57) The invention provides an arrangement and method for detecting shorts between solder pads 31-34 in the production testing of circuit boards. The invention is particularly suitable for circuits driven by a constant current source or sink 6. By providing a conductor 101 -103 between the solder pads, connected by a resistive path 11 to a source of potential 12, an additional current will flow through the resistive path to the solder pads if a short circuit exists in the region wherein the conductor is positioned. The additional current can be detected by applying a test probe in a circuit including the solder pads. A method for detecting whether a polarity sensitive component (1, Fig 4A) has been correctly connected is also disclosed.

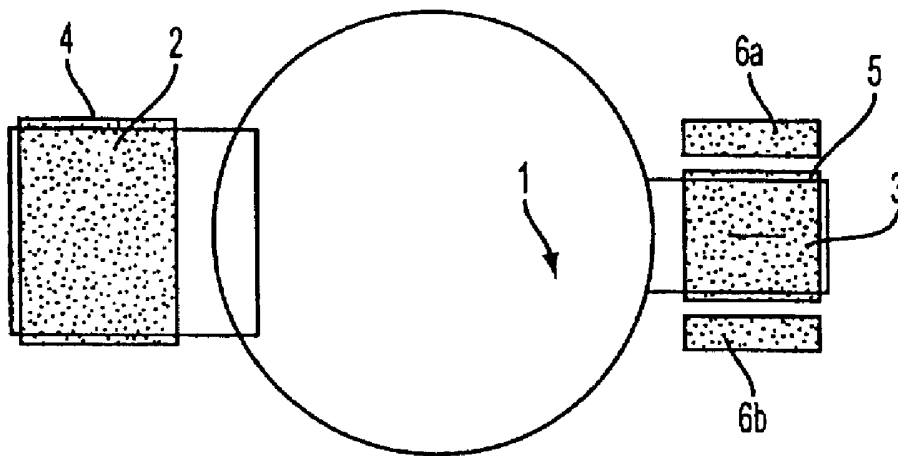


FIG. 4A

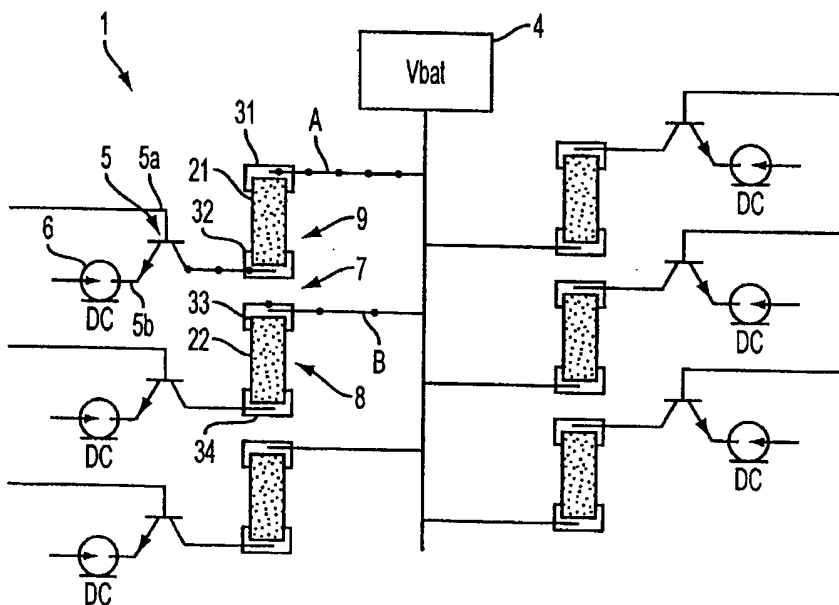


FIG. 1

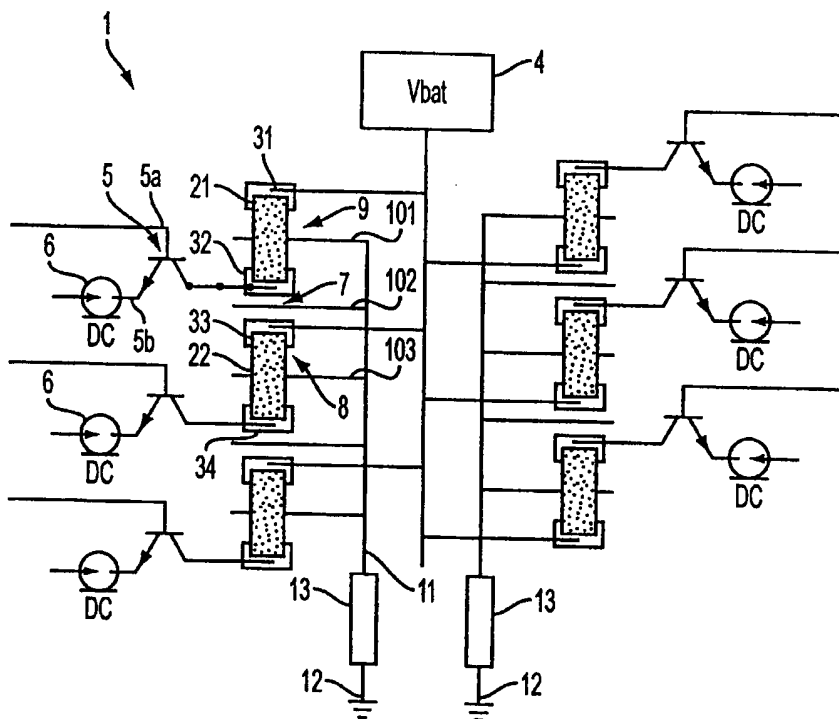
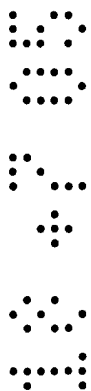


FIG. 2



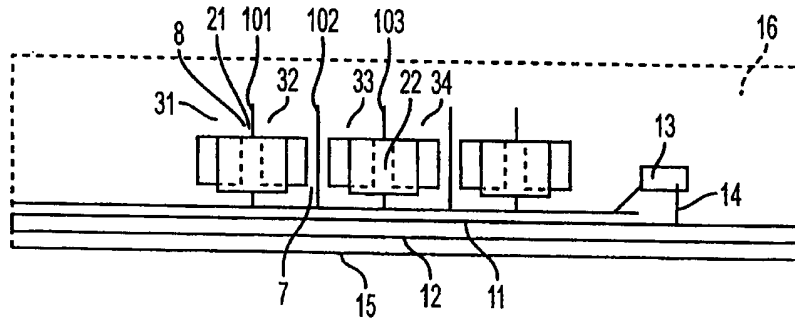


FIG. 3

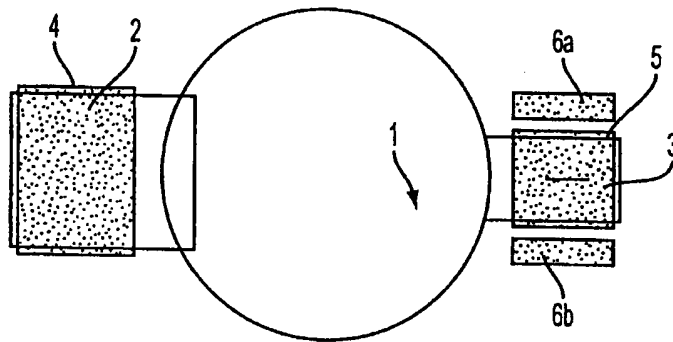


FIG. 4A

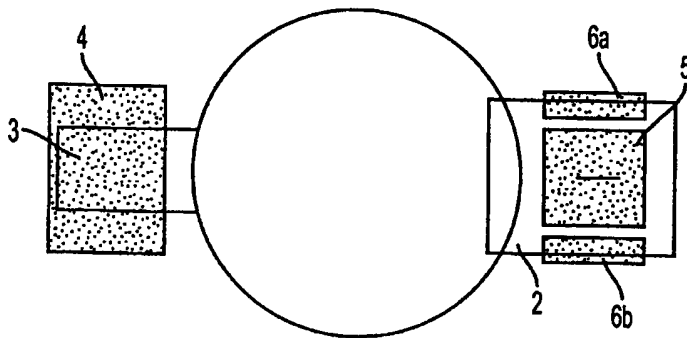


FIG. 4B

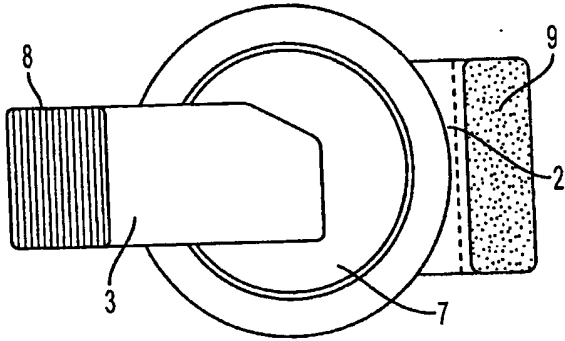


FIG. 5A

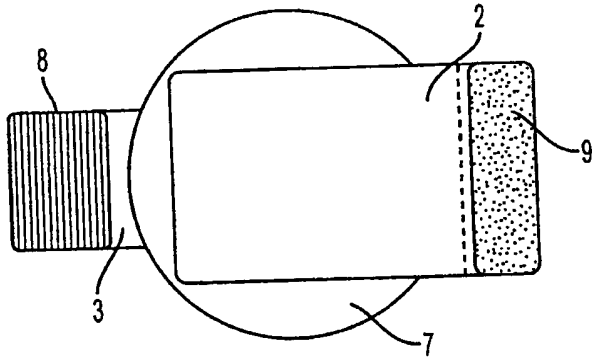


FIG. 5B

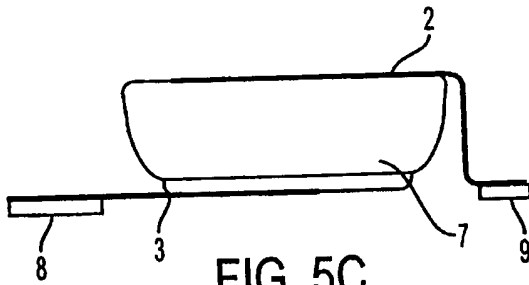


FIG. 5C

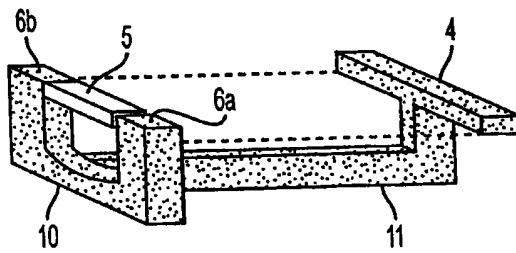
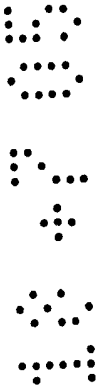


FIG. 6



Detecting Short Circuits and Detecting Component Misplacement

Description

This invention relates to an arrangement and to a method for detecting short
5 circuits on a board. More specifically, but not exclusively, it relates to detecting
shorts in a circuit on a Printed Wire Board wherein the circuit is driven by a
constant current sink. Additionally, it relates to an arrangement on a board for
receiving a polarity sensitive component, and to a method of testing if a component
is wrongly connected to an arrangement.

10

During and after production of electronic circuit boards for use in for example
radiotelephones, displays and various electronic gadgets, the components on the
electronic circuit boards and the circuit connecting them need to be tested to detect
15 faults in the components and also faults arising during the assembly. Typical faults
include short circuits between solder pads created during soldering. If the short
circuits are not detected, faulty products can be released for sale.

Hence, there is a demand for cost-effective detection of short circuits on Printed
Wire Boards and similar. A conventional method of detecting short circuits
20 comprises using a test equipment to detect the current flowing through one or more
components of a circuit. If the circuit is driven by a voltage source, the resistance
of the components limits the amount of current flowing through them. Thus, if a
short-circuit allows current to take a different path and avoid the components, a
current different to that expected may be detected and, thus, the short circuit can be
25 detected.

An example of a circuit wherein a constant power source is beneficial is a circuit
comprising a plurality of LEDs. Due to the nature of LEDs, they can easily be
damaged by connecting them to a voltage source higher than its turn on voltage. A
30 good LED driver circuit is, therefore, either a constant current sink or an
approximation to a current sink made by connecting the LED in series with a
suitable current limiting resistor and a voltage source. However, the conventional

method of detecting shorts between LEDs may not work when the circuit is powered by a constant current sink.

The invention aims to ameliorate the problems discussed above.

5

According to the invention there is provided an arrangement comprising two adjacent solder pads on a surface of a board, and a conductor located between and non-contacting the solder pads, the conductor forming part of a path to a first source of potential.

10

Preferably the path is a resistive path, since this has certain advantages. However, the path could be a simple conductor connection to the first source of potential.

One of the solder pads can be connected to a constant current sink. Also one of the solder pads may be connected to a second source of potential, different from the first. The conductor may have an open circuit at one end. Thus, if there is a short between the two adjacent solder pads, there is also a short between the solder pad and the conductor, and the potential difference in the path will result in an additional current flowing through the short-circuited solder pad. Consequently, the current in a circuit comprising at least one of the two short-circuited solder pads will be different from the expected current, and the short-circuit can be detected. One end of the conductor can be an open circuit. One end of the same or another conductor can be a short circuit.

25 According to the invention there is also provided a method of testing an arrangement comprising two adjacent solder pads on a surface of a board, and a conductor located between and non-contacting the solder pads, the conductor forming part of a path to a first source of potential, the method comprising applying a testing potential to an electrical circuit including at least one of the solder pads so that the testing potential being different than the potential of the first source of potential, detecting a current resulting from applying the testing potential, and determining the existence of a short circuit based on the detected current.

30

Another example of a fault that may arise during manufacture of electronic goods includes a components connected wrongly. Most components can be tested before release of the product. However, some components may appear to be working properly at the testing stage but may stop working correctly at a later stage. One
5 such example is a polarity sensitive capacitor used as a back up power source in a device. A conventional way of testing the correct placement of a capacitor comprises applying a voltage to a circuit including the capacitor in order to allow it to charge up and subsequently to check whether it has charged, i.e. if there is a potential difference present across it. However, a polarised capacitor connected the
10 wrong way around could exhibit a voltage across it but eventually, during use, it could break down and stop functioning correctly. Thus, a method of testing if a polarity sensitive components are accurately connected is needed.

The invention aims to provide a solution.

15

According to another aspect of the invention, there is provided an arrangement on a board for receiving a polarity sensitive component having first and second terminals, the arrangement comprising a first connector intended to be connected to the first terminal, a second connector intended to be connected to the second
20 terminal, and an auxiliary connector electrically coupled to the first connector and juxtaposed with the second connector so that, if the component is wrongly placed, the first terminal connects the second connector with the auxiliary connector.

The component may be a capacitor.

25

The first terminal preferably is wider than the second terminal. The first terminal may also be wider than the width of the second conductor and the auxiliary conductor combined. Thus, if the polarity sensitive component is placed in contact with the second conductor, it will also contact the auxiliary conductor so that a
30 current can follow a path short-circuiting the component. This can allow the fault to be detected during production testing.

According to the invention there is also provided a method of testing if a polarity sensitive component, having first and second terminals, is wrongly connected to an arrangement on a board having a first connector intended to be connected to the first terminal, a second connector intended to be connected to the second terminal, and an auxiliary connector electrically coupled to the first connector and juxtaposed with the second connector so that, if the component is wrongly placed, the first terminal connects the second connector with the auxiliary connector, the method comprising applying a potential difference in a circuit comprising said first, second and auxiliary connectors, and measuring the potential difference across the polarity sensitive component, determining if the polarity sensitive component has been wrongly connected to the arrangement based on the detected potential difference.

Embodiments of the present inventions will now be described, by way of example, with reference to the accompanying drawings, in which:

- Figure 1 is a schematic drawing of a circuit to be tested for short circuits;
Figure 2 is a schematic drawing of the circuit of Figure 1 and an arrangement according to the invention for detecting short circuits;
Figure 3 shows how the arrangement of Figure 2 is implemented on a Printed Wire Board (PWB);
Figure 4a is a schematic drawing of a electronic component correctly connected and soldered to connectors on a board;
Figure 4b is a schematic drawing of the electronic component wrongly connected to connectors on a board;
Figure 5a to 5c illustrates the structure of the electronic component of Figure 4a and 4b;
Figure 6 shows a perspective view of an arrangement on a board according to the invention.

Figure 1 shows a circuit 1 comprising light emitting diodes (LED) 21, 22, each connected by way of a plurality of solder pads 31-34. LED 21 is soldered to solder pads 31 and 32 and LED 22 is soldered to solder pads 33 and 34. The LEDs 21, 22 are further connected in parallel to a battery 4 providing a source of potential in the circuit. Each LED 21, 22 is further connected to a respective switch 5, constituted

by an npn transistor. A gate electrode 5a of the switch 5 is connected to a control circuit (not shown), and one other terminal of the switch 5a is connected to a constant current sink 6. Any two adjacent solder pads are separated by gaps 7, 8 or 9. Solder pads 31 and 32 are separated by gap 9, solder pads 32 and 33 are separated by gap 7 and solder pads 33 and 34 are separate by gap 8. The circuit, 5 except the LEDs 21, 22, is printed on a Printed Wire Board (not shown).

In order to operate one of the LEDs, the switch 5 connected to the LEDs 21, 22 is closed by applying a voltage to its gate electrode 5a. When the switch is closed, 10 electrons from the constant current sink 6 flows through the LED to switch it on.

In the production testing of the circuit 1 in Figure 1, it is difficult to determine if there is a short circuit in the gaps 7 or 8. If a test probe is coupled to the circuit between the battery and the LED 21, the electrons flowing through solder pad 31 15 can be detected. If gaps 7 and 9 do not short circuit, the electrons will follow a path A, extending from solder pad 32, through the LED 21 and solder pad 31 to the battery 4. On the other hand, if gap 7 is short circuited, connecting the adjacent solder pads 32 and 33, the electrons will take path B extending from solder pad 32 to solder pad 33 and then to battery 4. However, since the LEDs 21, 22 are driven 20 by a constant current sink 6, the current through path A and B is the same, so the short circuit cannot be detected.

Figure 2 shows an arrangement according to one aspect of the invention. Reference numerals are retained from Figure 1 for like elements. In Figure 2, conductors 101- 25 103 are connected in the regions between two adjacent solder pads. Conductors 101 and 103 are positioned underneath LEDs 21 and 22 respectively. Conductor 102 is positioned between solder pads 32 and 33. The conductors 101-103 are further connected through a resistive path 11 to a source of potential 12. The source of potential 12 is at ground potential. The resistive path 11 includes a 30 resistor 13. If there is a short circuit between any two adjacent solder pads 31-34, at least one of the tracks 101-103 is in electrical contact with at least one of the solder pads and, due to the potential difference between the ground track 11 and the solder pad, a current flows in the resistive path 11. This results in a different

current being detected by the testing apparatus connected to the test probe.

Although the path 11 is described as being resistive, the path could instead be a simple track connecting directly to ground potential 12.

5 Figure 3 is a plan view of a surface of a printed wire board 16, wherein the solid line 15 shows one side edge of the printed wire board. Reference numerals are retained from Figure 1 and from Figure 2 for like elements. Track 12 in Figure 3 is connected to ground potential. The LEDs 21, 22 are soldered to the solder pads 31, 32, 33 and 34, as described with reference to Figure 1 and Figure 2. The edges of
10 the solder pads covered by the upper surface of the LEDs are shown in broken lines. Moreover, conductors 101-103 comprise tracks between the solder pads 31-34, which tracks are connected together and to a resistor 13. The resistor 13 is connected to ground potential 12 by a track 14. The conductors 101, 103 in the gaps 8 and 9 are positioned on the surface of the board inbetween the solder pads
15 and underneath the respective LED 21 and 22. The conductor 102 in gap 7 is positioned on the surface of the board, in between the LEDs 21 and 22. Each LED 21 and 22 is connected to a constant current sink and to a source of potential (not shown in Figure 3). The gaps 7, 8 and 9 between the solder pads are relatively narrow, significantly smaller than the width of the solder pads. Accordingly, during
20 soldering, a short may occasionally be formed between the solder pads across the gaps 7 and 8.

Testing is carried out as described above in relation to Figure 2, namely the circuit is powered and a test probe (not shown), applying a testing potential which is different
25 to the potential supplied by the battery 4, is connected to the circuit between a battery and an LED 21, 22. If there is a short circuit between one of the solder pads 31-34 and one of the conductors 101-103, the current flowing through the test probe will be different to the current that would flow if there were no short circuit. Test apparatus including the test probe may make a short circuit determination in
30 any suitable way, as will be appreciated by the skilled person.

It should be noted that the invention is not limited to the circuits of Figure 2 and Figure 3. The production testing of any circuit driven by a constant or generally

constant current sink or source may be improved by the invention. Moreover, the solder pads do not have to be used for connecting LEDs, but could be used for various other electronic component in a circuit. Moreover, the number of conductors 101-103 connected to the resistive path can be varied in order to adapt the arrangement according to the circuit to be tested. The resistive path 11 does not need to be connected to ground potential, but could instead be connected to any suitable source of potential. Moreover, the conductors 101-103 do not have to end in the regions between the solder pads, and thereby provide an open circuit. They can be connected to an additional source of potential in a resistive or non-resistive path. Moreover, one or both of the resistors shown in Figure 1 and 2 can be removed from the circuit.

Figure 4a shows an electronic component 1, having a positive terminal 2 and a negative terminal 3 connected respectively to a positive component connector pad 4 and a negative component connector pad 5 on a board (not shown). The positive terminal 2 is intended to be connected to the positive connector pad 4 and the negative terminal 3 is intended to be connected to the negative connector pad 5. In Figure 4a the connectors 4, 5 are in the form of conducting pads. The positive terminal 2 has a larger width than the negative terminal 3. Similarly, the positive pad 4 has a larger width than the negative pad 5. The terminals 2, 3 of component 1 are soldered onto the pads 3, 4. The electronic component 1 is polarity sensitive. Thus, if it is not connected the right way around, it may not work properly. Here, the electronic component 1 is a capacitor. The component 1 will hereinafter be referred to as a capacitor but will be understood not to be limited to a capacitor. The capacitor 1 may be used as a back-up source of power in a circuit. A conventional method of testing if a capacitor is connected properly is to charge it up and then measure the potential difference between its terminals. In a conventional arrangement for receiving the capacitor, the capacitor would become charged to some extent and could pass the test even if it was wrongly connected.

Figure 4b shows the capacitor 1 wrongly connected. However, according to the invention, there are provided two auxiliary connectors 6a and 6b in the form of pads. Pads 6a and 6b are electrically coupled to each other and to the positive pad

4. The connections are shown in Figure 6 described below. They are located such that when the large positive terminal 2 of the capacitor 1 is connected to the small negative pad 5, the positive terminal 2 will also connect to at least one of the auxiliary pads 6a and 6b. Thus, the capacitor 1 is shorted and will not be charged when a potential is applied to the pads 3 and 4. Consequently, after a voltage, which normally would charge the capacitor 1, has been applied, the voltage across the capacitor would be significantly lower than expected and the circuit would fail the production test. The capacitor 1 could then be realigned or replaced.

10 Figure 5a shows a plan view of the lower surface of the capacitor 1, i.e. the surface closest to the circuit board. The negative terminal 3 is generally rectangular, and is attached to the main body 7 of the capacitor 1. The negative terminal 3 includes an area 8 with solder plating, for soldering the terminal 3 to the pad 5 of the circuit board. Figure 5b shows a plan view of the top surface of the capacitor 1. The positive terminal 2 is generally rectangular and has a larger width and larger area than the negative terminal 3. Here, the width of the positive terminal is 3mm and the width of the negative terminal is 2mm. The positive terminal 2 is attached to the main body 7 of the capacitor 1. The positive terminal 2 moreover comprises a region 9 comprising solder plating for soldering the terminal to the pad 4 of the circuit board, although the solder is located on the opposite side of the terminal shown in the Figure. The positive terminal 2 is bent perpendicular to the surface of the battery as shown in the side view of the battery in Figure 5c. Thus, the regions 8 and 9 of the first and second terminals are in the same plane and can be soldered to the pads 4, 5 on the circuit board.

25

One embodiment of the connector pads 4, 5, 6a, 6b is shown in Figure 6. Reference numerals are retained from Figures 4 and 5 for like elements. The auxiliary pads 6a, 6b are connected directly to the positive pad 4 by way of a U-shaped conductor 10, which connects the pads 6a and 6b, and a conductor 11, below the surface of the circuit board, leading to the positive pad from the conductor 10. The plane of the surface of the circuit board is illustrated by the broken line.

30

The manner in which the auxiliary conductors 6a, 6b and the positive conductor 4 are connected together can be varied. In an alternative embodiment, the auxiliary conductors 6a, 6b and the positive conductor 4 can be connected to a common track of a printed wire board. Moreover, the shape, size and number of auxiliary
5 pads can be varied without deviating from the invention as claimed in the claims.

Claims

1. An arrangement comprising
two adjacent solder pads on a surface of a board, and
5 a conductor located between and non-contacting the solder pads, the
conductor forming part of a path to a first source of potential.
2. The arrangement of claim 1 wherein one or more of the solder pads is
connected to a generally constant current sink or source.
- 10 3. The arrangement of claim 1 or 2 wherein one of the solder pads is connected
to a second source of potential, different from the first source of potential.
4. The arrangement of any one of the preceding claims, wherein the path
15 includes a resistor.
5. The arrangement of any one of the preceding claims, wherein one end of the
conductor is an open circuit.
- 20 6. The arrangement of any one of the preceding claims, wherein the distance
between said two adjacent solder pads is such that there is a significant probability
of a short being created thereacross during soldering.
7. The arrangement of claim 6, wherein the solder pads are larger than the
25 distance between the solder pads.
8. The arrangement of claim 6, wherein the solder pads are smaller than the
distance between the solder pads.
- 30 9. The arrangement of any one of the preceding claims wherein the surface of
the board supports plural solder pads and conductor arrangements.
10. A radiotelephone including the board of claim 9.

11. A method of testing an arrangement comprising two adjacent solder pads on a surface of a board, and a conductor located between and non-contacting the solder pads, the conductor forming part of a path to a first source of potential, the
5 method comprising
applying a testing potential to an electrical circuit including at least one of the solder pads, the testing potential being different to the potential of the first source of potential,
detecting a current resulting from applying the testing potential, and
10 determining the existence of a short circuit based on the detected current.
12. The method of claim 11 wherein the detecting step comprises determining if the detected current deviates from an expected current.
13. An arrangement on a board for receiving a polarity sensitive component having first and second terminals, the arrangement comprising:
a first connector intended to be connected to the first terminal,
a second connector intended to be connected to the second terminal, and
an auxiliary connector electrically coupled to the first connector and
20 juxtaposed with the second connector so that, if the component is wrongly placed, the first terminal connects the second connector with the auxiliary connector.
14. The arrangement of claim 13, wherein the operative area of the first connector is about the same as that of the second and auxiliary connectors
25 combined.
15. The arrangement of claims 13 or 14, wherein the auxiliary connector is directly connected to the first connector.
16. The arrangement of any one of claims 13 to 15 arranged to receive a polarity
30 sensitive capacitor.
17. The arrangement of any one of claims 13 to 16 arranged to receive a polarity

sensitive back up power source.

18. The arrangement of any one of claims 13 to 17, wherein the first terminal is wider than the second terminal.

5

19. The arrangement of claim 13 to 18 wherein the first terminal is wider than the second connector.

20. A method of testing if a polarity sensitive component, having first and second terminals, is wrongly connected to an arrangement on a board having a first connector intended to be connected to the first terminal, a second connector intended to be connected to the second terminal, and an auxiliary connector electrically coupled to the first connector and juxtaposed with the second connector so that, if the component is wrongly placed, the first terminal connects the second connector with the auxiliary connector, the method comprising:

15

applying a potential difference in a circuit comprising said first, second and auxiliary connectors, and

detecting a potential difference across the polarity sensitive component,

determining if the polarity sensitive component has been wrongly connected to the arrangement based on the detected potential difference.

20



13



INVESTOR IN PEOPLE

Application No: GB0412179.4

Examiner: James Hull

Claims searched: 1 to 12

Date of search: 27 September 2005

Patents Act 1977: Search Report under Section 17

Documents considered to be relevant:

Category	Relevant to claims	Identity of document and passage or figure of particular relevance
X	1 to 4, 6 to 10	GB2047973 A SONY CORP. See Figs. Conductors 9, 10 located between solder pads / lands 7a, 7b.
A	.	US5877033 A THE FOXBORO CO. See Figs. System for detection of unsoldered components.

Categories:

X	Document indicating lack of novelty or inventive step	A	Document indicating technological background and/or state of the art.
Y	Document indicating lack of inventive step if combined with one or more other documents of same category.	P	Document published on or after the declared priority date but before the filing date of this invention.
&	Member of the same patent family	E	Patent document published on or after, but with priority date earlier than, the filing date of this application.

Field of Search:

Search of GB, EP, WO & US patent documents classified in the following areas of the UKC^X :

G1U; H1R

Worldwide search of patent documents classified in the following areas of the IPC⁰⁷

G01R; H05K

The following online and other databases have been used in the preparation of this search report

WPI, EPODOC